

International **IR** Rectifier

HEXFET® POWER MOSFET **THRU-HOLE (TO-39)**

PD - 94340A

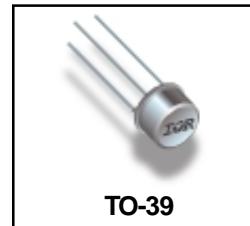
IRF7F3704
20V, N-CHANNEL

Product Summary

Part Number	BVDSS	RDS(on)	ID
IRF7F3704	20V	0.035Ω	12A*

Seventh Generation HEXFET® power MOSFETs from International Rectifier utilize advanced processing techniques to achieve the lowest possible on-resistance per silicon unit area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient device for use in a wide variety of applications.

These devices are well-suited for applications such as switching power supplies, motor controls, inverters, choppers, audio amplifiers and high-energy pulse circuits.



Features:

- Low RDS(on)
- Avalanche Energy Ratings
- Dynamic dv/dt Rating
- Simple Drive Requirements
- Ease of Parallelizing
- Hermetically Sealed
- Light Weight

Absolute Maximum Ratings

	Parameter		Units
ID @ VGS = 10V, TC = 25°C	Continuous Drain Current	12*	A
ID @ VGS = 10V, TC = 100°C	Continuous Drain Current	12*	
IDM	Pulsed Drain Current ①	48	
PD @ TC = 25°C	Max. Power Dissipation	20	W
	Linear Derating Factor	0.16	W/°C
VGS	Gate-to-Source Voltage	±20	V
EAS	Single Pulse Avalanche Energy ②	190	mJ
IAR	Avalanche Current ①	12	A
EAR	Repetitive Avalanche Energy ①	2.0	mJ
dv/dt	Peak Diode Recovery dv/dt ③	0.5	V/ns
TJ	Operating Junction	-55 to 150	°C
TSTG	Storage Temperature Range		
	Lead Temperature	300 (0.063 in./1.6mm from case for 10s)	
	Weight	0.98 (Typical)	g

* Current is limited by package

For footnotes refer to the last page

Electrical Characteristics @ $T_j = 25^\circ\text{C}$ (Unless Otherwise Specified)

	Parameter	Min	Typ	Max	Units	Test Conditions
BV_{DSS}	Drain-to-Source Breakdown Voltage	20	—	—	V	$\text{V}_{\text{GS}} = 0\text{V}, \text{I}_D = 250\mu\text{A}$
$\Delta \text{BV}_{\text{DSS}}/\Delta T_j$	Temperature Coefficient of Breakdown Voltage	—	0.024	—	$\text{V}/^\circ\text{C}$	Reference to 25°C , $\text{I}_D = 1.0\text{mA}$
$\text{R}_{\text{DS(on)}}$	Static Drain-to-Source On-State Resistance	—	—	0.035	Ω	$\text{V}_{\text{GS}} = 10\text{V}, \text{I}_D = 12\text{A}$ ④
		—	—	0.04		$\text{V}_{\text{GS}} = 4.5\text{V}, \text{I}_D = 12\text{A}$
$\text{V}_{\text{GS(th)}}$	Gate Threshold Voltage	1.0	—	3.0	V	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{I}_D = 250\mu\text{A}$
g_{fs}	Forward Transconductance	20	—	—	S (m^2)	$\text{V}_{\text{DS}} = 10\text{V}, \text{I}_{\text{DS}} = 12\text{A}$ ④
I_{DSS}	Zero Gate Voltage Drain Current	—	—	20	μA	$\text{V}_{\text{DS}} = 20\text{V}, \text{V}_{\text{GS}} = 0\text{V}$
		—	—	100		$\text{V}_{\text{DS}} = 16\text{V}, \text{V}_{\text{GS}} = 0\text{V}, \text{T}_j = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Leakage Forward	—	—	100	nA	$\text{V}_{\text{GS}} = -20\text{V}$
I_{GSS}	Gate-to-Source Leakage Reverse	—	—	-100		$\text{V}_{\text{GS}} = -20\text{V}$
Q_g	Total Gate Charge	—	—	19	nC	$\text{V}_{\text{GS}} = -4.5\text{V}, \text{I}_D = 12\text{A}$
Q_{gs}	Gate-to-Source Charge	—	—	8.0		$\text{V}_{\text{DS}} = 10\text{V}$
Q_{gd}	Gate-to-Drain ('Miller') Charge	—	—	6.0		
$t_{\text{d(on)}}$	Turn-On Delay Time	—	—	30	ns	$\text{V}_{\text{DD}} = 10\text{V}, \text{I}_D = 12\text{A}, \text{V}_{\text{GS}} = 4.5\text{V}, \text{R}_G = 1.8\Omega$
t_r	Rise Time	—	—	175		
$t_{\text{d(off)}}$	Turn-Off Delay Time	—	—	175		
t_f	Fall Time	—	—	100		
$\text{L}_{\text{S}} + \text{L}_{\text{D}}$	Total Inductance	—	7.0	—	nH	Measured from drain lead (6mm/0.25in. from package) to source lead (6mm/0.25in. from package)
C_{iss}	Input Capacitance	—	1860	—	pF	$\text{V}_{\text{GS}} = 0\text{V}, \text{V}_{\text{DS}} = 10\text{V}$ $f = 1.0\text{MHz}$
C_{oss}	Output Capacitance	—	990	—		
Crss	Reverse Transfer Capacitance	—	55	—		

Source-Drain Diode Ratings and Characteristics

	Parameter	Min	Typ	Max	Units	Test Conditions
I_S	Continuous Source Current (Body Diode)	—	—	12*	A	
I_{SM}	Pulse Source Current (Body Diode) ①	—	—	48		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$\text{T}_j = 25^\circ\text{C}, \text{I}_S = 12\text{A}, \text{V}_{\text{GS}} = 0\text{V}$ ④
t_{rr}	Reverse Recovery Time	—	—	57	ns	$\text{T}_j = 25^\circ\text{C}, \text{I}_F = 12\text{A}, \text{di/dt} \leq 100\text{A}/\mu\text{s}$
Q_{RR}	Reverse Recovery Charge	—	—	60	nC	$\text{V}_{\text{DD}} \leq 16\text{V}$ ④
ton	Forward Turn-On Time	Intrinsic turn-on time is negligible. Turn-on speed is substantially controlled by $\text{L}_{\text{S}} + \text{L}_{\text{D}}$.				

* Current is limited by package

Thermal Resistance

	Parameter	Min	Typ	Max	Units	Test Conditions
R_{thJC}	Junction-to-Case	—	—	6.25	$^\circ\text{C}/\text{W}$	
R_{thJA}	Junction-to-Ambient	—	—	175		Typical socket mount

Note: Corresponding Spice and Saber models are available on the Website.

For footnotes refer to the last page

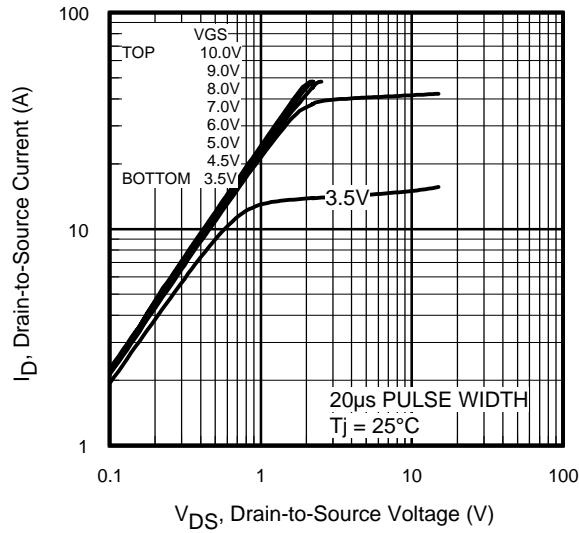


Fig 1. Typical Output Characteristics

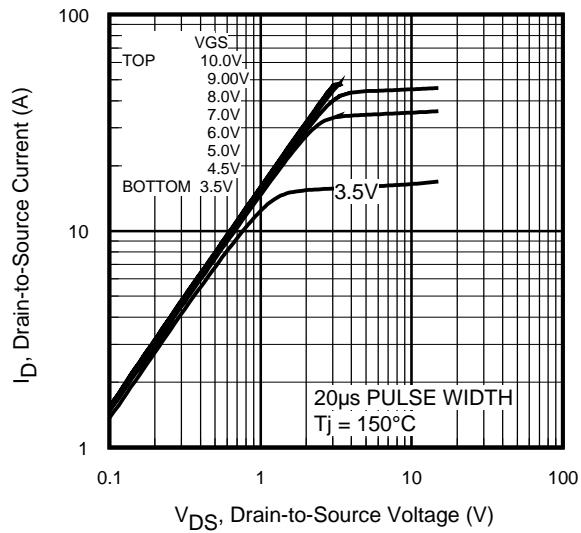


Fig 2. Typical Output Characteristics

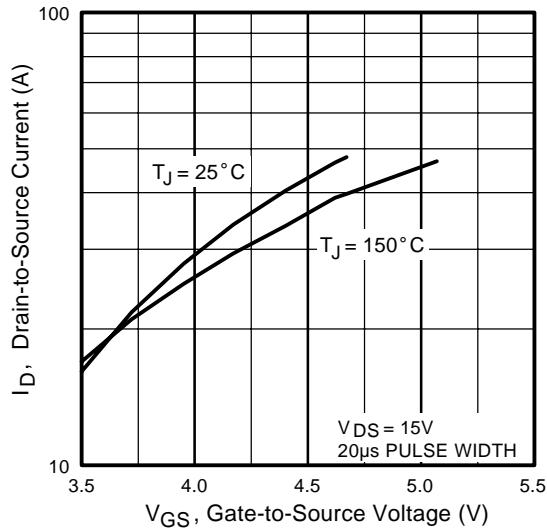


Fig 3. Typical Transfer Characteristics

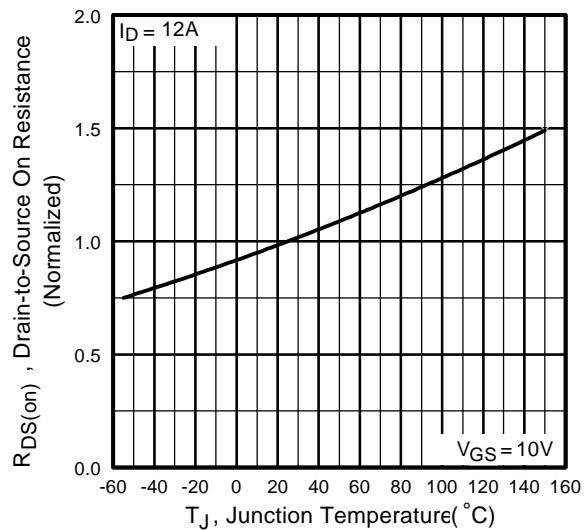


Fig 4. Normalized On-Resistance
Vs. Temperature

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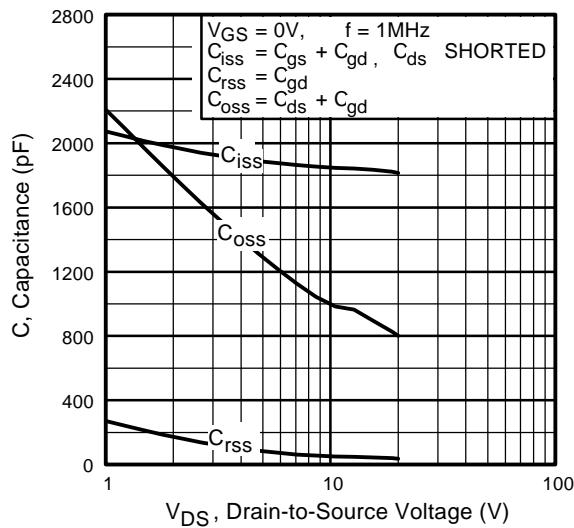


Fig 5. Typical Capacitance Vs.
Drain-to-Source Voltage

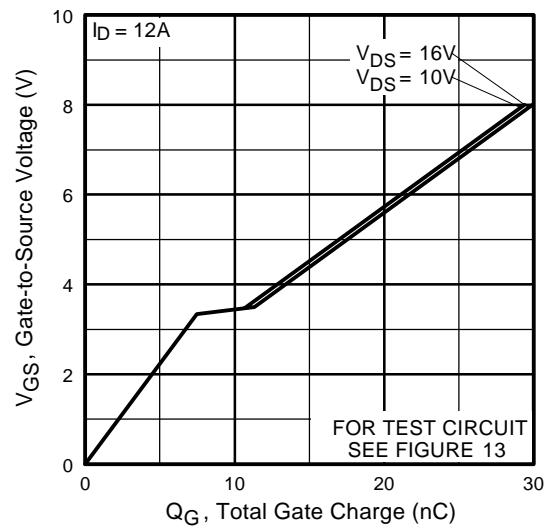


Fig 6. Typical Gate Charge Vs.
Gate-to-Source Voltage

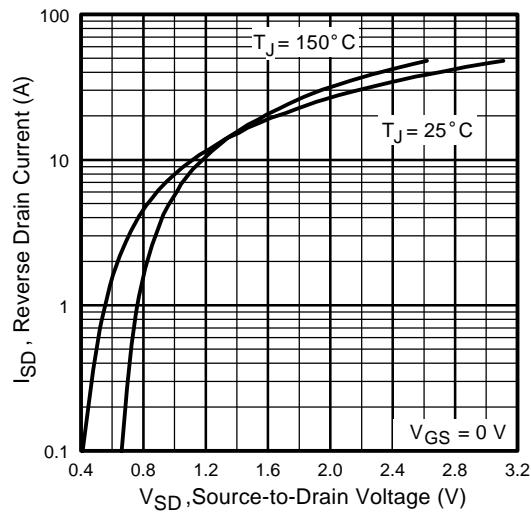


Fig 7. Typical Source-Drain Diode
Forward Voltage

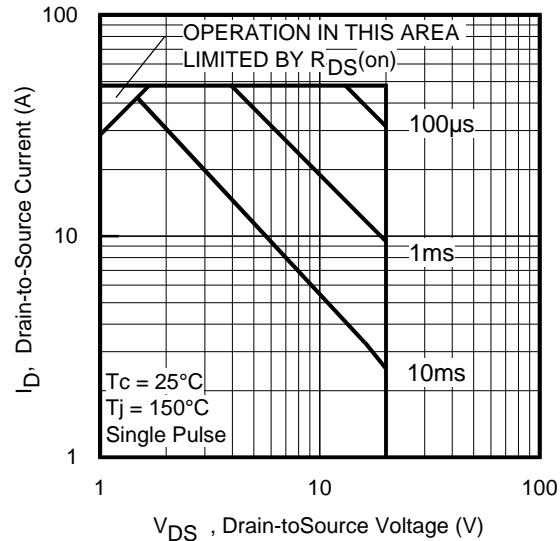


Fig 8. Maximum Safe Operating Area

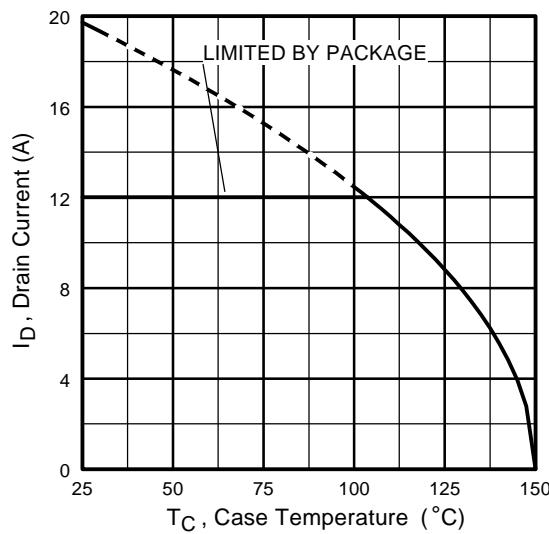


Fig 9. Maximum Drain Current Vs.
Case Temperature

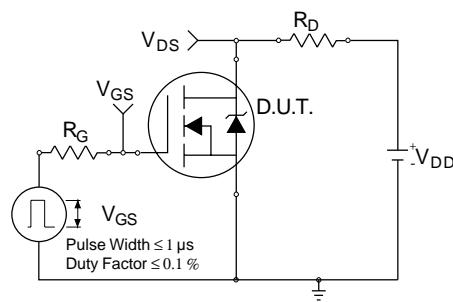


Fig 10a. Switching Time Test Circuit

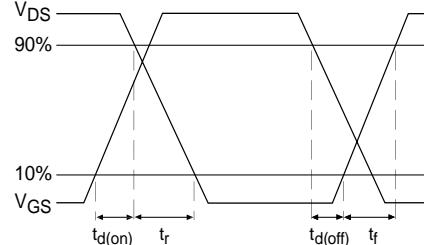


Fig 10b. Switching Time Waveforms

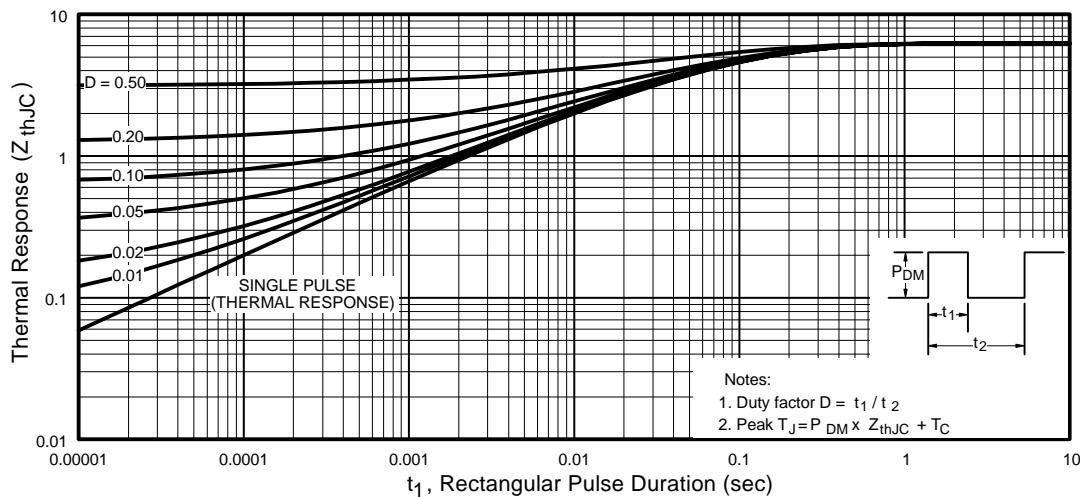


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

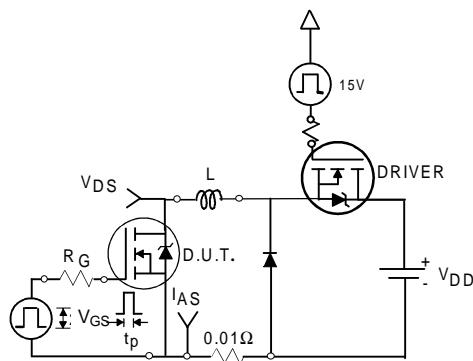


Fig 12a. Unclamped Inductive Test Circuit

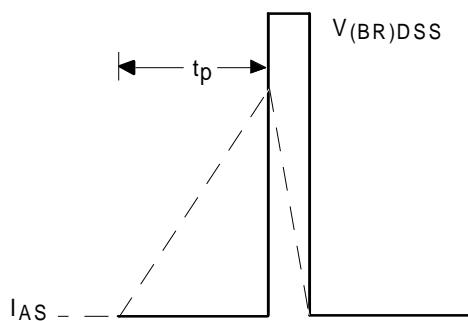


Fig 12b. Unclamped Inductive Waveforms

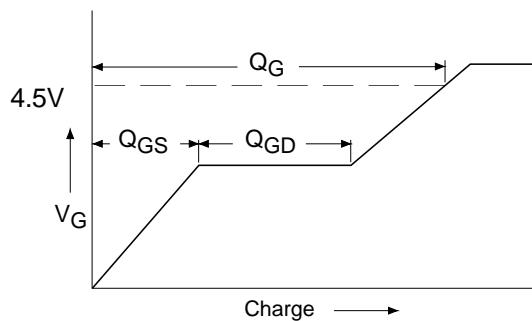


Fig 13a. Basic Gate Charge Waveform

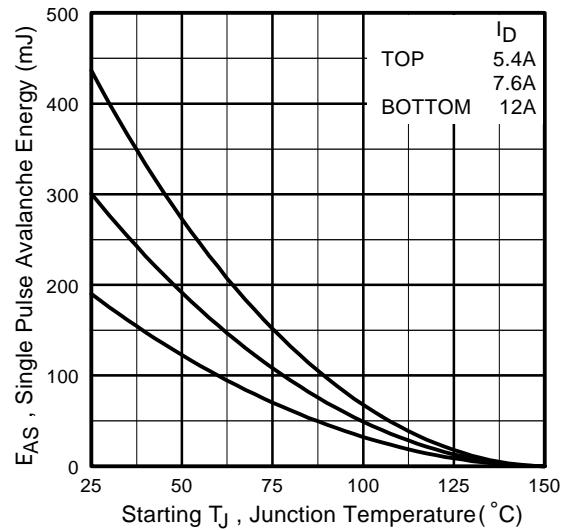


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

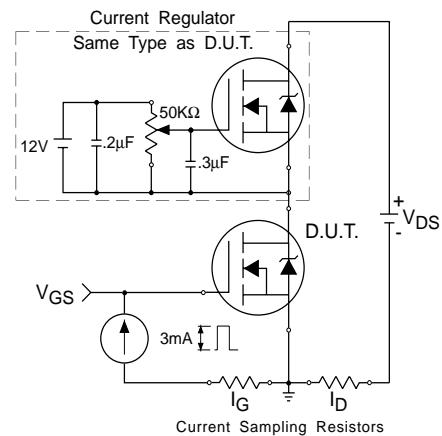


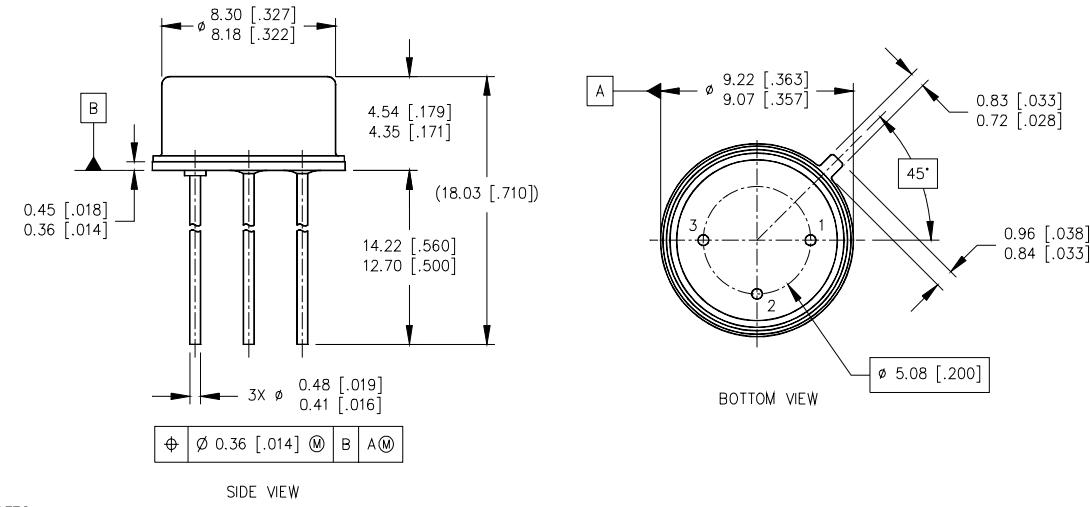
Fig 13b. Gate Charge Test Circuit

Footnotes:

- ① Repetitive Rating; Pulse width limited by maximum junction temperature.
- ② V_{DD} = 15 V, Starting T_J = 25°C, L = 2.7mH
Peak I_{AS} = 12A, V_{GS} = 10V, R_G = 25Ω

- ③ I_{SD} ≤ 12A, di/dt ≤ 80A/μs,
V_{DD} ≤ 20V, T_J ≤ 150°C
- ④ Pulse width ≤ 300 μs; Duty Cycle ≤ 2%

Case Outline and Dimensions — TO-205AF (Modified TO-39)



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME 14.5M-1994.
2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
3. CONTROLLING DIMENSION: INCH.
4. CONFORMS TO JEDEC OUTLINE TO-205AF (TO-39).

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Data and specifications subject to change without notice. 02/02